

<i>Supplemental</i> <b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)				ATTY DOCKET NO. 1800/3		SERIAL NO. 10/087,204									
				Avery Li-Chun Wang et al.											
				FILING 03/01/02		GROUP 2185									
U.S. PATENT DOCUMENTS															
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE									
12. <i>eleh</i>	4,918,730	4/17/90	Schulze	381	43										
13.	4,843,562	6/27/89	Kenyon et al.	364	487										
14.	4,739,398	4/19/98	Thomas et al.	358	84										
15.	4,450,531	5/22/84	Kenyon et al.	364	604										
16.	4,230,990	10/28/80	Lert, Jr. et al.	455	67										
<div style="position: relative; height: 100px;"> <div style="position: absolute; top: 0; right: 0; text-align: right;"> <b>RECEIVED</b>  <b>NOV 05 2002</b>  <b>Technology Center 2100</b> </div> </div>															
FOREIGN PATENT DOCUMENTS															
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION									
6. <i>eleh</i>	WO 93/22875	11/11/93	PCT	H04N 7	10	✓									
7.	WO 93/07689	04/15/93	PCT	H04B 17	00	✓									
8.	WO 91/17540	11/14/99	PCT	G10L 5	06	✓									
9. <i>↓</i>	WO 99/48099	9/23/99	PCT	G11B 23	087		✓								
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)															
EXAMINER <i>E. Plakaus</i>				DATE CONSIDERED <i>1/27/04</i>											
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.															

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EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
1. <i>Elek</i>	5,991,737	11/23/99	Chen	705	26		
2.	5,918,223	6/29/99	Blum et al.	707	1		
3.	5,842,162	11/24/98	Fineberg	704	223		
4.	5,787,334	7/28/98	Fardeau et al.	455	2		
5.	5,581,800	12/3/96	Fardeau et al.	455	2		
6.	5,581,658	12/3/96	O'Hagan et al.	395	22		
7.	5,577,249	11/19/96	Califano	395	6 <sup>H</sup>	<b>RECEIVED</b> <b>NOV 05 2002</b> <b>Technology Center 2100</b>	
8.	5,574,962	11/12/96	Fardeau et al.	455	2		
9.	5,437,050	7/25/95	Lamb et al.	455	2		
10.	5,210,820	5/11/93	Kenyon	395	2		
11. <i>✓</i>	5,134,719	7/28/92	Mankovitz	455	154.1		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
1. <i>Elek</i>	EP 0 982 578 A2	03/01/2000	EP	G01M 13	02	✓	
2.	WO 97/40491	10/30/97	PCT	G10L 5	06	✓	
3.	WO 97/33273	9/12/97	PCT	G10L 5	06	✓	
4.	EP 0 480 010 B1	9/11/96	EP	G10L 5	06	✓	
5. <i>✓</i>	WO 94/00842	01/06/94	PCT	G11B 17	22	✓	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>EP Release</i>				DATE CONSIDERED <i>9/27/04</i>			
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